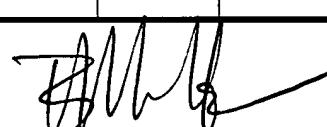


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/003,831	NAKANO ET AL.
	Examiner	Art Unit
	Aaron W. Carter	2625

ISSUE CLASSIFICATION												
ORIGINAL		CROSS REFERENCE(S)										
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)									
382	145	382	149	151								
INTERNATIONAL CLASSIFICATION		438	16									
G	0	6	K	9/00	348	87						
H	0	1	L	23/544	257	E23.17 9						
				/	356	237.1						
				/								
				/								
Aaron Carter <i>AAC</i> 9/8/2005 (Assistant Examiner) (Date) Sharmenpre 9-13-05 (Legal Instruments Examiner) (Date)					 BHAVESH M. MEHTA <small>(Primary Examiner)</small> SUPERVISORY PATENT EXAMINER <small>(Date)</small> TECHNOLOGY CENTER 2600					Total Claims Allowed: 4 O.G. Print Claim(s) O.G. Print Fig. 13		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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5	35	65	95	125		155	185
6	36	66	96	126		156	186
7	37	67	97	127		157	187
8	38	68	98	128		158	188
9	39	69	99	129		159	189
10	40	70	100	130		160	190
11	41	71	101	131		161	191
12	42	72	102	132		162	192
13	43	73	103	133		163	193
14	44	74	104	134		164	194
15	45	75	105	135		165	195
16	46	76	106	136		166	196
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18	48	78	108	138		168	198
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23	53	83	113	143		173	203
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25	55	85	115	145		175	205
26	56	86	116	146		176	206
27	57	87	117	147		177	207
28	58	88	118	148		178	208
29	59	89	119	149		179	209
30	60	90	120	150		180	210